

Title (en)
PROCESS OF TESTING AND ELECTRONIC CONTROL UNIT

Title (de)
TESTVERFAHREN UND ELEKTRONISCHE STEUERUNGSEINHEIT

Title (fr)
PROCEDE D'ESSAI TECHNIQUE ET UNITÉ ÉLECTRONIQUE DE COMMANDE

Publication
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Application
EP 14825377 A 20141024

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Abstract (en)
[origin: WO2015067872A1] The invention relates to the field of technical trials and specifically to a technical trial method for assessing at least one device operation parameter (X) across a series of operation increments, each one of which corresponds to a stable value of at least one operation rule of the device. The method includes at least: time sampling (S201) Tau values minus an operation parameter (X); filtering (S206) the sampled values in order to obtain a filtered signal (Xfilt) for each operation parameter (X); calculating (S208) the variance of the values sampled for each operation parameter (X) in a sampling window during said operation increment ; calculating (S205) the absolute value of the time derivative of the filtered signal (Xfilt) for each operation parameter (X); and changing (S211) the value of said at least one operation rule when, for each operation parameter (X), said variance of the sampled values and the absolute value of the time derivative of the filtered signal (Xfilt) are less than respective predetermined bottom thresholds.

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Citation (search report)
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